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Hydrothermal and electrochemical growth of complex oxide thin films for electronic devices

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Abstract

Thin film growth of complex oxides including BaTiO₃, SrTiO₃, BaZrO₃, SrZrO₃, KTaO₃, and KNbO₃ were studied by the hydrothermal and the hydrothermal–electrochemical methods. Hydrothermal–electrochemical growth of ATiO₃ ($A = Ba$, Sr) thin films was investigated at temperatures from 100 to 200 ◦C using a three-electrode cell. Current efficiency for the film growth was in the range from ca. 0.6 to 3.0%. Tracer experiments revealed that the ATiO₃ film grows at the film/substrate interface. Thin films of AZrO₃ (A = Ba, Sr) were also prepared on Zr metal substrates by the hydrothermal–electrochemical method. By applying a potential above ca. +2 V versus Ag/AgCl to the Zr substrates, $AZrO₃$ thin films were formed uniformly. Thin films of KTaO₃ and KNbO₃ were prepared on Ta metal substrates by the hydrothermal method. Perovskite-type KTaO₃ thin films were formed in 2.0 M KOH at 300 °C. Pyrochlore-type K₂Ta₂O₆ thin films were formed at lower temperatures and lower KOH concentrations.

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1. Introduction

Synthesis of complex oxide thin films has been extensively investigated mainly because of their electromagnetic properties such as ferroelectricity, pyroelectricity, piezoelectricity, electro-optic properties, etc. After the initial prepara-tion of BaTiO₃ thin film using flash evaporation in [1](#page-5-0)955,¹ these oxide thin films have been tried to prepare mainly through dry processes including vacuum evaporation, 2 rf and magnetron sputterings, $3,4$ MOCVD,^{[5](#page-6-0)} laser deposition,^{[6](#page-6-0)} and reactive evaporation. In contrast, the hydrothermal and the hydrothermal–electrochemical methods are those novel thin film formation techniques which make positive use of hydrothermal and electrochemical reactions between the substrate and species included in the synthesis solution.^{[7–9](#page-6-0)} For example, these methods permit a perovskitetype compound ABO₃ to be synthesized on a substrate of B-site metal immersed in a synthesis solution containing A-site ions under hydrothermal conditions. The synthesis temperatures required to obtain crystalline phases in this method are generally below about 300 ◦C, which are fairly lower than the above-mentioned common film-formation techniques. The present paper concerns thin film growths of complex oxides including BaTiO₃, SrTiO₃, BaZrO₃, $SrZrO₃$, KTaO₃, and KNbO₃ by the hydrothermal and the hydrothermal–electrochemical methods.

2. Experimental procedure

2.1. Hydrothermal–electrochemical treatments

In case of syntheses of ATiO₃ (A = Ba, Sr) and AZrO₃ $(A = Ba, Sr)$ thin films, titanium and zirconium metal substrates with $>99\%$ purity and dimensions of 50 mm \times $20 \text{ mm} \times 0.5 \text{ mm}$ were mechanically polished to a mirror finish. A platinum plate with \geq 99.0% purity of the same

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Fig. 1. Schematic figure of electrolytic cell of three-electrode arrangement. The cell is assembled in an autoclave and equipped with a Ti or Zr working electrode, a Pt counter electrode, and a Ag/AgCl external reference electrode.

dimensions was also prepared. Prior to the hydrothermal– electrochemical treatment, the Ti and Zr substrates and the Pt plate were degreased in acetone with an ultrasonic cleaner, etched in a chromic acid mixture for about 16 h, and then washed in distilled water with the ultrasonic cleaner. Guaranteed reagent grade $Ba(OH)2.8H2O$ and $Sr(OH)₂·8H₂O$ was used to prepare $A(OH)₂$ (A = Ba, Sr) solutions. Hydrothermal–electrochemical treatments were performed in an autoclave fabricated on the basis of the three-electrode cell arrangement with an Ag/AgCl external reference electrode shown in Fig. 1. A metal substrate and a platinum plate of the same dimensions were suspended as the working and the counter electrodes, respectively, by 0.5-mmdiameter wires of the same metal as the respective electrodes, maintaining a separation of 30 mm between them in the electrolytic cell containing 200–500 mL of a synthesis solution.

Fig. 2. Relation between temperature profile (lower) and potentiostatic electrolysis adopted in the present study (upper). The electrolysis is performed from 50° C in the heating region to the end of the isothermal region of the temperature profile. The potential of the Ti electrode is represented in units of volts vs. Ag/AgCl electrode. The hatched area below the electrolysis current curve corresponds to the quantity of electricity passed.

The electrolysis was performed potentiostatically from 50 ◦C in the heating process to the end of the isothermal process as shown in Fig. 2.

2.2. Hydrothermal treatments

In case of syntheses of $KMO₃$ (M = Ta, Nb) thin films, tantalum metal substrates with >99.9% purity and dimensions of $10 \text{ mm} \times 10 \text{ mm} \times 0.5 \text{ mm}$ were mechanically polished. Prior to the hydrothermal treatment, the Ta substrates were washed in NaOH solution, degreased in acetone with an ultrasonic cleaner, etched in a chromic acid mixture for about 16 h, and then washed in distilled water with the ultrasonic cleaner. Guaranteed reagent grade KOH and $Nb₂O₅$ were used to prepare KOH solutions including $Nb₂O₅$. Hydrothermal treatments at temperatures in the range from 150 to 400 \degree C were performed in a Hastelloy-C lined microautoclave containing 6–10 mL of KOH solution and the Ta substrate shown in Fig. 3. In order to investigate the crystal symmetry and the lattice constants of hydrothermally synthesized $KMO₃$ (M = Ta, Nb), powder samples were also prepared using guaranteed reagent grade Ta₂O₅, Nb₂O₅, and KOH.

2.3. Characterization

Film-constituting phases and their lattice parameters were analyzed by X-ray diffractometry (XRD, RINT 1500, Rigaku Denki) under the operating conditions of 40 kV-100 mA, using Cu K α radiation with a graphite monochromator and a silicon powder (Si-640b, U.S. Department of Commerce, NIST). Microstructure of the grown films was investigated

Fig. 3. Schematic figure of Hastelloy-C lined autoclave used for hydrothermal synthesis.

using scanning electron microscopy (SEM, S-4000, Hitachi) at an acceleration voltage of 10–20 kV, and by transmission electron microscopy (TEM, H-9000UHR, Hitachi) at an acceleration voltage of 300 kV. Compositional analysis was performed using scanning transmission electron microscopy (STEM, HB501, VG Microscopes) at an acceleration voltage of 100 kV, incorporating energy dispersive X-ray spectroscopy (EDX, KEVEX SUPER8000, Fisons Instruments) with a probe beam of 1-nm diameter and 1-nA current. Metal/insulator/metal structures were fabricated by depositing an array of 2.0-mm-diameter Ag or Al films on the film surface to measure electrical properties. Leakage current–voltage characteristics and dielectric breakdown voltages were measured with a voltage current source (TR6163, Advantest) and with a picoammeter (TR8641D, Advantest). Dependence of capacitance and dielectric loss on dc bias voltage and temperature was measured with an LCR meter (HP4284A, Hewlett-Packard). Frequency dependence of capacitance and dielectric loss was evaluated with an impedance analyzer (YHP4194A, Yokogawa-Hewlett-Packard). A ferroelectric tester (RT6000HVS, Radiant Technologies) was used to measure polarization-voltage hysteresis loops.

3. Results and discussion

3.1. Growth of ATiO3 (A = Ba, Sr) thin film on titanium substrate by the hydrothermal–electrochemical method

A novel hydrothermal–electrochemical method has been developed to prepare dielectric thin films of $ATiO₃$ (A = Ba,

Fig. 4. Amount of $SrTiO₃$ formed per unit surface area and corresponding film thickness estimated by gravimetry as a function of the quantity of electricity for various Ti electrode potentials (vs. Ag/AgCl). Inset shows slopes corresponding to several typical values of current efficiency.

Sr) on Ti substrates with accurate control of the film thickness up to ca. 2 μ m. The cubic lattice parameter of the SrTiO3 film was analyzed to be 3.919 Å . The film thickness increased monotonically with an increase in the quantity of electricity passed through the Ti electrode, and could be controlled coulometrically by this factor as depicted in Fig. 4. The quantity of electricity of ca. 200 C/cm² were required for growing a ca. 2-µm-thick SrTiO₃ film on a Ti substrate under typical potentiostatic electrolysis conditions at +12.0 V versus Ag/AgCl in 0.5 M Sr(OH)₂ solution of pH 14.2 at 150 °C. The standard errors at the 95% confidence level for the regressions of the film thickness to the quantity of electricity in Fig. 4 were estimated to be less than ± 0.05 μ m. Current efficiency for the film growth was estimated to be in the range from ca. 0.6 to 3.0%, mainly depending on the Ti electrode potential and the synthesis temperature. Solid-solution films in the system Ba $TiO₃ - SrTiO₃$ were also grown on Ti electrodes with control of the Ba/Sr composition in $(Ba, Sr)(OH)_2$ solutions.

The mass transport mechanism during the hydrothermal– electrochemical growth of polycrystalline thin films of ATiO₃ $(A = Ba, Sr)$ perovskite onto Ti electrodes in $A(OH)_2$ solutions was studied by a tracer technique, using Ba and 18 O atoms as respective tracers for A-site and oxygen atoms in $SrTiO₃$ host films. It was found that the ATiO₃ film grows at the film/electrode interface by transport of both A-site and oxygen atoms from the solution to the interface. A-site and oxygen atoms are considered to diffuse as constituents of solution species, such as A^{2+} , OH⁻, and H₂O, through open short-circuit paths existing at grain boundaries.

Microstructures of $SrTiO₃$ thin films grown on Ti substrates by the hydrothermal–electrochemical method were

Fig. 5. SEM micrograph of a ca. 2-µm-thick SrTiO₃ film grown on a Ti substrate by the hydrothermal–electrochemical method with potentiostatic electrolysis at $+8.0$ V vs. Ag/AgCl in 0.5 M Sr(OH)₂ solution of pH 14.2 at 150° C.

studied by scanning and transmission electron microscopy. The grown films consisted of a thin surface layer having an isotropic polycrystalline structure and a thick inner layer having a columnar structure (Fig. 5). Pores of the order of several tens of nanometers were found at boundaries of columnar grains constituting the inner layer. A 20- or 30-nm-thick polycrystalline layer of Ti oxides contaminated with a small amount of Sr was also found at the $SrTiO₃ film/Ti$ substrate interface ([Fig. 6\).](#page-4-0) During the film growth at this interface, the observed pores are considered to act as short-circuit paths for mass transport from the film surface to the interface.

Electrical measurements were performed on $BaTiO₃$ thin films grown by the hydrothermal–electrochemical method. Resistivities as high as $10^{12} \Omega$ cm were obtained in the voltage range up to $2V$ for the 0.40- μ m-thick BaTiO₃ thin film and its breakdown voltage was higher than 12 V. The grown films were paraelectric with dielectric constants of 340–350 and dielectric losses of $7-10\%$ at 1 kHz, $0.1 \text{ V}_{\text{rms}}$, and 25° C.

3.2. Growth of AZrO3 (A = Ba, Sr) thin film on zirconium substrate by the hydrothermal–electrochemical method

Thin films of $AZrO₃$ were prepared on Zr metal sub-strates by the hydrothermal–electrochemical method.^{[10](#page-6-0)} The electrolysis current flowed through the Zr substrate and the resulting surface morphology of grown film largely depended on the electrode potential applied to the substrate, as shown in [Figs. 7 and 8.](#page-4-0) Under pure hydrothermal conditions, $AZrO₃$ microcrystals with diameters of several micrometers were formed sparsely on the Zr substrates. By applying a potential

Fig. 6. Magnified TEM image of the SrTiO₃ film/Ti substrate interface of the $SrTiO₃$ film. Arrows indicate boundaries of a polycrystalline layer of Ti oxides whose microstructure is different from the columnar one of the overlying, inner SrTiO3 layer.

above ca. $+2$ V versus Ag/AgCl to the Zr substrates, AZrO₃ thin films could be synthesized on them uniformly. Solidsolution films in the system $BaZrO₃ - SrZrO₃$ were also grown on Zr substrates with control of the Ba/Sr composition in (Ba, Sr)(OH)₂ solutions. Thus the electrochemical treatment was confirmed to be effective for fabricating $AZrO₃$ thin films, similarly as for $ATiO₃$ thin films.

Fig. 7. Variation of current density curve with Zr electrode potential (V vs. Ag/AgCl). Synthesis conditions: $0.5 M Ba(OH)_2$, $150 °C$, 4h.

Fig. 8. SEM images of $(Ba, Sr)ZrO₃$ microcrystals formed under (a) hydrothermal and (b) electrolysis conditions. Synthesis conditions: 0.5 M $(Ba_{0.5}Sr_{0.5})(OH)_2$, +8.0 V vs. Ag/AgCl, 150 °C, 4 h.

3.3. Growth of KMO3 (M = Ta, Nb) thin film on tantalum substrate by the hydrothermal method

Thin films of $KMO₃$ were prepared on Ta metal substrates in KOH solutions by the hydrothermal method.^{[11](#page-6-0)} [Fig. 9](#page-5-0) shows a phase formation diagram at a synthesis temperature of 300 °C. Phase-pure perovskite-type KTaO₃ thin films were formed at KOH concentrations of 4.0 M or above, depending on the synthesis time. Pyrochlore-type $K_2Ta_2O_6$ thin films were formed at lower KOH concentrations. Lattice constant of the KTaO₃ was almost the same as that in JCPDS-PDF, whereas lattice constant of $K_2Ta_2O_6$ was 0.2% larger than the PDF value. It was revealed by TG and IR measurements that the $K_2Ta_2O_6$ pyrochlore contains several percent of OH group whereas the $KTaO₃$ perovskite contains only a smaller amount of OH group. [Fig. 10](#page-5-0) depicts the difference in IR spec-

Fig. 9. Formation diagram of KTaO₃ perovskite and K₂Ta₂O₆ pyrochlore in the hydrothermal system KOH–Ta–H2O at a synthesis temperature of 300 °C. (\bullet) KTaO₃, (\square) K₂Ta₂O₆.

trum due to OH group at about 3300 cm^{-1} . Solid-solution films in the system $KTaO_3-KNbO_3$ were also grown on Ta substrates with control of the Nb content in the KOH solutions, as shown in Fig. 11.

Fig. 10. IR spectra of KTaO₃ perovskite and K₂Ta₂O₆ pyrochlore with/without heating at 1000 °C for 4 h in air. (a) $K_2Ta_2O_6$ without heating, (b) $K_2Ta_2O_6$ with heating, (c) KTaO₃ without heating, (d) KTaO₃ with heating. Synthesis conditions: 8.0 M KOH, 200–300 ◦C, 12 h.

Fig. 11. XRD patterns (Cu K α) of potassium tantalate niobate films formed at various Nb concentrations. The *X* in K(Ta_{1 – *X*}Nb_{*X*})O₃ is estimated from its lattice volume. Synthesis conditions: 4–40 mM Nb, 1.0 M KOH, 400 ◦C, 8 h.

4. Summary

Thin films of $ATiO₃$ (A = Ba, Sr) were grown by the hydrothermal–electrochemical method with current efficiency of ca. $0.6-3.0\%$. The ATiO₃ films were found to grow at the film/substrate interface by transport of both A-site and oxygen atoms from the solution to the interface through shortcircuit paths. Thin films of $AZrO₃$ (A = Ba, Sr) were also prepared uniformly by the hydrothermal–electrochemical method, applying a potential above ca. +2 V versus Ag/AgCl to the Zr substrates. Thin films of $KTaO₃$ containing only a smaller amount of OH group were formed by the hydrothermal method at 300 ◦C.

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References

- 1. Feldman, C., Formation of thin films of BaTiO₃ by evaporation. *Rev. Sci. Inst.*, 1955, **26**(5), 463–466.
- 2. Tomashpolski, Y. Y., Structure studies of ferroelectric vacuum deposits. *Ferroelectrics*, 1974, **7**, 253–255.
- 3. Pratt, I. H., Characteristics of RF sputtered barium titanate thin films. *Proc. IEEE*, 1971, **59**(10), 1440–1447.
- 4. Sakuma, T., Yamamichi, S., Matsubara, S., Yamaguchi, H. and Miyasaka, Y., Barrier layers for realization of high capacitance den-

sity in SrTiO3 thin-film capacitor on silicon. *Appl. Phys. Lett.*, 1990, **57**(23), 2431–2433.

- 5. Feil, W. A., Wessels, B. W., Tonge, L. M. and Marks, T. J., Organometallic chemical vapor deposition of strontium titanate. *J. Appl. Phys.*, 1990, **67**(8), 3858–3861.
- 6. Hiratani, M., Tarutani, Y., Fukazawa, T., Okamoto, M. and Takagi, K., Growth of SrTiO₃ thin films by pulsed-laser deposition. *Thin Solid Films*, 1993, **227**, 100–104.
- 7. Yoshimura, M., Yoo, S. E., Hayashi, M. and Ishizawa, N., Preparation of BaTiO3 thin film by hydrothermal electrochemical method. *Jpn. J. Appl. Phys.*, 1989, **28**(2), L2007–L2009.
- 8. Kajiyoshi, K., Ishizawa, N. and Yoshimura, M., Preparation of tetragonal barium titanate thin film on titanium metal substrate

by hydrothermal method. *J. Am. Ceram. Soc.*, 1991, **74**(2), 369– 374.

- 9. Kajiyoshi, K., Ishizawa, N. and Yoshimura, M., Heteroepitaxial growth of BaTiO₃ thin films on SrTiO₃ substrates under hydrothermal conditions. *Jpn. J. Appl. Phys.*, 1991, **30**(1B), L120–L123.
- 10. Kajiyoshi, K., Goto, S., Onda, A. and Yanagisawa, K., Preparation of $AZrO₃$ (A = Ba, Sr) thin films by the hydrothermal-electrochemical method. In *Preprints of the 14th Fall Meeting of the Ceramic Society of Japan*, 2001, p. 281.
- 11. Kajiyoshi, K., Ike, R., Onda, A. and Yanagisawa, K., Hydrothermal syntheses of potassium tantalate niobate thin films. In *Preprints of the 2003 Annual Meeting of the Ceramic Society of Japan*, 2003, p. 48.